BAW62
High-speed diode

Product specification
Supersedes data of April 1992
File under Discrete Semiconductors, SC01

1996 Apr 04
High-speed diode

FEATURES

• Hermetically sealed leaded glass SOD27 (DO-35) package
• High switching speed: max. 4 ns
• Continuous reverse voltage: max. 75 V
• Repetitive peak reverse voltage: max. 75 V
• Repetitive peak forward current: max. 450 mA
• Forward voltage: max. 1 V.

APPLICATIONS

• High-speed switching
• Fast logic applications.

DESCRIPTION

The BAW62 is a high-speed switching diode fabricated in planar technology, and encapsulated in the hermetically sealed leaded glass SOD27 (DO-35) package.

![Simplified outline (SOD27; DO-35) and symbol.](image)

The diode is type branded.

Fig.1 Simplified outline (SOD27; DO-35) and symbol.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

<table>
<thead>
<tr>
<th>SYMBOL</th>
<th>PARAMETER</th>
<th>CONDITIONS</th>
<th>MIN.</th>
<th>MAX.</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{RRM}$</td>
<td>repetitive peak reverse voltage</td>
<td>–</td>
<td>–</td>
<td>75</td>
<td>V</td>
</tr>
<tr>
<td>$V_R$</td>
<td>continuous reverse voltage</td>
<td>–</td>
<td>–</td>
<td>75</td>
<td>V</td>
</tr>
<tr>
<td>$I_F$</td>
<td>continuous forward current</td>
<td>see Fig.2; note 1</td>
<td>–</td>
<td>250</td>
<td>mA</td>
</tr>
<tr>
<td>$I_{FRM}$</td>
<td>repetitive peak forward current</td>
<td>–</td>
<td>–</td>
<td>450</td>
<td>mA</td>
</tr>
<tr>
<td>$I_{FSM}$</td>
<td>non-repetitive peak forward current</td>
<td>square wave; $T_j = 25^\circ C$ prior to surge; see Fig.4</td>
<td>–</td>
<td>0.5</td>
<td>A</td>
</tr>
<tr>
<td></td>
<td></td>
<td>$t = 1 \mu s$</td>
<td>–</td>
<td>4</td>
<td>A</td>
</tr>
<tr>
<td></td>
<td></td>
<td>$t = 1 ms$</td>
<td>–</td>
<td>1</td>
<td>A</td>
</tr>
<tr>
<td></td>
<td></td>
<td>$t = 1 s$</td>
<td>–</td>
<td>0.5</td>
<td>A</td>
</tr>
<tr>
<td>$P_{tot}$</td>
<td>total power dissipation</td>
<td>$T_{amb} = 25^\circ C$; note 1</td>
<td>–</td>
<td>350</td>
<td>mW</td>
</tr>
<tr>
<td>$T_{stg}$</td>
<td>storage temperature</td>
<td>–</td>
<td>–</td>
<td>+200</td>
<td>°C</td>
</tr>
<tr>
<td>$T_j$</td>
<td>junction temperature</td>
<td>–</td>
<td>–</td>
<td>200</td>
<td>°C</td>
</tr>
</tbody>
</table>

Note

1. Device mounted on an FR4 printed circuit-board; lead length 10 mm.
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### ELECTRICAL CHARACTERISTICS

\( T_j = 25 \, ^\circ\text{C} \); unless otherwise specified.

<table>
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<tr>
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<th>MIN.</th>
<th>MAX.</th>
<th>UNIT</th>
</tr>
</thead>
</table>
| \( V_F \) | forward voltage | see Fig.3  
  \( I_F = 5 \, \text{mA} \)  
  \( I_F = 100 \, \text{mA} \)  
  \( I_F = 100 \, \text{mA}; T_j = 100 \, ^\circ\text{C} \) | 620 | 750 | mV |

| \( I_R \) | reverse current | see Fig.5  
  \( V_R = 20 \, \text{V} \)  
  \( V_R = 50 \, \text{V} \)  
  \( V_R = 75 \, \text{V} \)  
  \( V_R = 20 \, \text{V}; T_j = 150 \, ^\circ\text{C} \)  
  \( V_R = 75 \, \text{V}; T_j = 150 \, ^\circ\text{C} \) | – | 25 | nA |

| \( C_d \) | diode capacitance | f = 1 MHz; \( V_R = 0 \); see Fig.6 | – | 2 | pF |

| \( t_{rr} \) | reverse recovery time | when switched from \( I_F = 10 \, \text{mA} \) to \( I_R = 10 \, \text{mA} \); \( R_L = 100 \, \Omega \); measured at \( I_R = 1 \, \text{mA} \); see Fig.7 | – | 4 | ns |

| \( V_{fr} \) | forward recovery voltage | when switched from \( I_F = 50 \, \text{mA} \); \( t_r = 20 \, \text{ns} \); see Fig.8 | – | 2.5 | V |

### THERMAL CHARACTERISTICS

<table>
<thead>
<tr>
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<th>PARAMETER</th>
<th>CONDITIONS</th>
<th>VALUE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( R_{th,j-tp} )</td>
<td>thermal resistance from junction to tie-point</td>
<td>lead length 10 mm</td>
<td>240</td>
<td>K/W</td>
</tr>
<tr>
<td>( R_{th,j-a} )</td>
<td>thermal resistance from junction to ambient</td>
<td>lead length 10 mm; note 1</td>
<td>500</td>
<td>K/W</td>
</tr>
</tbody>
</table>

**Note**

1. Device mounted on a printed circuit-board without metallization pad.
Graphical Data

**Fig. 2** Maximum permissible continuous forward current as a function of ambient temperature.

Device mounted on an FR4 printed-circuit board; lead length 10 mm.

**Fig. 3** Forward current as a function of forward voltage.

(1) $T_j = 175\, ^\circ C$; typical values.
(2) $T_j = 25\, ^\circ C$; typical values.
(3) $T_j = 25\, ^\circ C$; maximum values.

**Fig. 4** Maximum permissible non-repetitive peak forward current as a function of pulse duration.

Based on square wave currents.

$T_j = 25\, ^\circ C$ prior to surge.
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Fig. 5 Reverse current as a function of junction temperature.

Fig. 6 Diode capacitance as a function of reverse voltage; typical values.

(1) $V_R = 75 \text{ V}$; maximum values.
(2) $V_R = 75 \text{ V}$; typical values.
(3) $V_R = 20 \text{ V}$; typical values.

$p = 1 \text{ MHz}; T_j = 25 ^\circ \text{C}$.
Fig. 7 Reverse recovery voltage test circuit and waveforms.

Fig. 8 Forward recovery voltage test circuit and waveforms.

(1) \( I_R = 1 \, \text{mA} \).
Philips Semiconductors Product specification

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PACKAGE OUTLINE

DEFINITIONS

<table>
<thead>
<tr>
<th>Data Sheet Status</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>Objective specification</td>
<td>This data sheet contains target or goal specifications for product development.</td>
</tr>
<tr>
<td>Preliminary specification</td>
<td>This data sheet contains preliminary data; supplementary data may be published later.</td>
</tr>
<tr>
<td>Product specification</td>
<td>This data sheet contains final product specifications.</td>
</tr>
</tbody>
</table>

Limiting values

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.